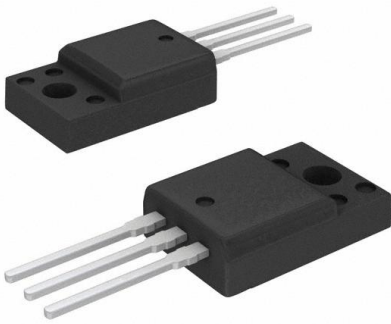


FQPF4N20 Datasheet

www.digi-electronics.com



<https://www.DiGi-Electronics.com>

DiGi Electronics Part Number	FQPF4N20-DG
Manufacturer	onsemi
Manufacturer Product Number	FQPF4N20
Description	MOSFET N-CH 200V 2.8A TO220F
Detailed Description	N-Channel 200 V 2.8A (Tc) 27W (Tc) Through Hole T O-220F-3



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

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Purchase and inquiry

Manufacturer Product Number:

FQPF4N20

Series:

QFET®

FET Type:

N-Channel

Drain to Source Voltage (Vdss):

200 V

Drive Voltage (Max Rds On, Min Rds On):

10V

Vgs(th) (Max) @ Id:

5V @ 250µA

Vgs (Max):

±30V

FET Feature:

-

Operating Temperature:

-55°C ~ 150°C (Tj)

Supplier Device Package:

TO-220F-3

Base Product Number:

FQPF4

Manufacturer:

onsemi

Product Status:

Obsolete

Technology:

MOSFET (Metal Oxide)

Current - Continuous Drain (Id) @ 25°C:

2.8A (Tc)

Rds On (Max) @ Id, Vgs:

1.40hm @ 1.4A, 10V

Gate Charge (Qg) (Max) @ Vgs:

6.5 nC @ 10 V

Input Capacitance (Ciss) (Max) @ Vds:

220 pF @ 25 V

Power Dissipation (Max):

27W (Tc)

Mounting Type:

Through Hole

Package / Case:

TO-220-3 Full Pack

Environmental & Export classification

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

REACH Status:

REACH Unaffected

HTSUS:

8541.29.0095



FQPF4N20

200V N-Channel MOSFET

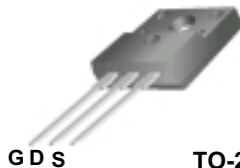
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

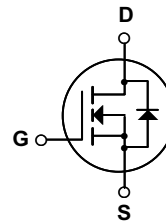
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply, DC-AC converters for uninterrupted power supply, motor control.

Features

- 2.8A, 200V, $R_{DS(on)} = 1.4\Omega @ V_{GS} = 10V$
- Low gate charge (typical 5.0 nC)
- Low Crss (typical 5.0 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-220F
FQPF Series



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	FQPF4N20	Units
V _{DSS}	Drain-Source Voltage	200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	2.8	A
		1.8	A
I _{DM}	Drain Current - Pulsed (Note 1)	11.2	A
V _{GSS}	Gate-Source Voltage	± 30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	52	mJ
I _{AR}	Avalanche Current (Note 1)	2.8	A
E _{AR}	Repetitive Avalanche Energy (Note 1)	2.7	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.5	V/ns
P _D	Power Dissipation (T _C = 25°C) - Derate above 25°C	27	W
		0.22	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

Thermal Characteristics

Symbol	Parameter	Typ	Max	Units
R _{θJC}	Thermal Resistance, Junction-to-Case	--	4.63	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	--	62.5	°C/W

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	200	--	--	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	--	0.24	--	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V	--	--	1	μA
		V _{DS} = 160 V, T _C = 125°C	--	--	10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	--	--	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	--	--	-100	nA

On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	3.0	--	5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.4 A	--	1.12	1.4	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 1.4 A (Note 4)	--	1.8	--	S

Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	--	170	220	pF
C _{oss}	Output Capacitance		--	35	45	pF
C _{rss}	Reverse Transfer Capacitance		--	5	7	pF

Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 100 V, I _D = 3.6 A, R _G = 25 Ω (Note 4, 5)	--	7	25	ns
t _r	Turn-On Rise Time		--	50	110	ns
t _{d(off)}	Turn-Off Delay Time		--	7	25	ns
t _f	Turn-Off Fall Time		--	25	60	ns
Q _g	Total Gate Charge		V _{DS} = 160 V, I _D = 3.6 A, V _{GS} = 10 V (Note 4, 5)	--	5.0	6.5
Q _{gs}	Gate-Source Charge		--	1.4	--	nC
Q _{gd}	Gate-Drain Charge		--	2.1	--	nC

Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	2.8	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	11.2	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.8 A	--	--	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 3.6 A, di _F / dt = 100 A/μs (Note 4)	--	90	--	ns
Q _{rr}	Reverse Recovery Charge		--	0.24	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 10mH, I_{AS} = 2.8A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C
3. I_{SD} ≤ 3.6A, di/dt ≤ 300A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

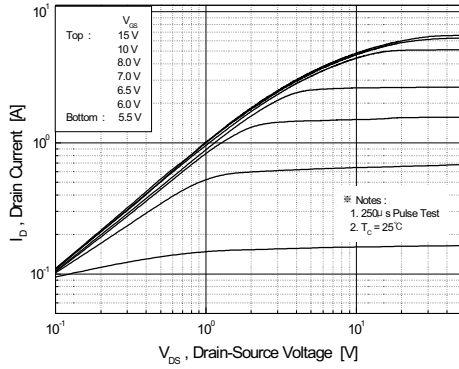


Figure 1. On-Region Characteristics

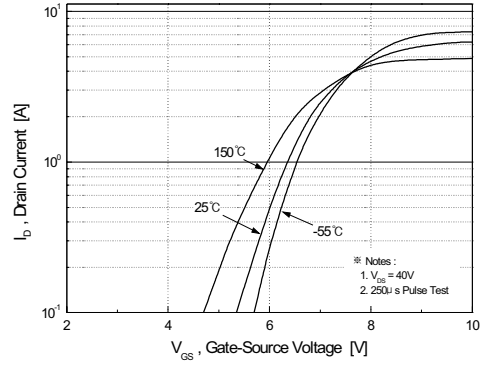


Figure 2. Transfer Characteristics

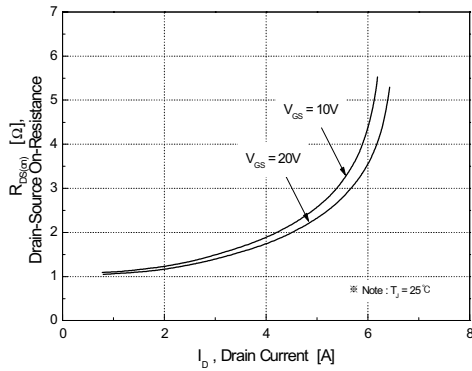


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

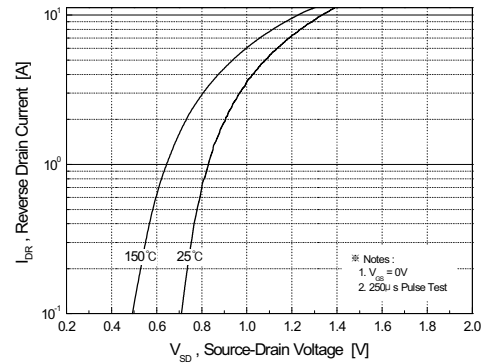


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

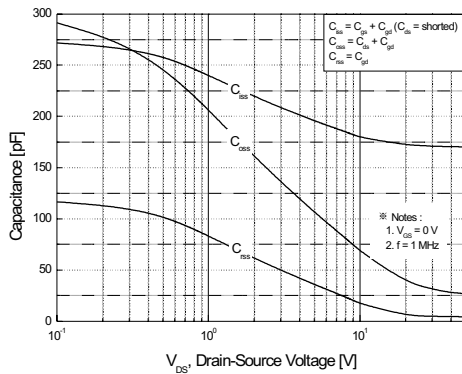


Figure 5. Capacitance Characteristics

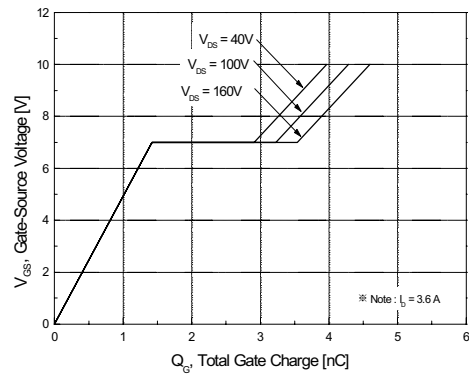


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

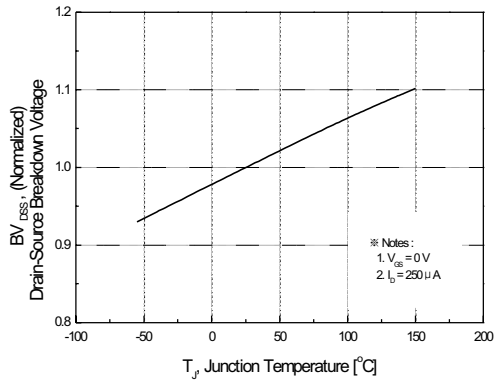


Figure 7. Breakdown Voltage Variation vs. Temperature

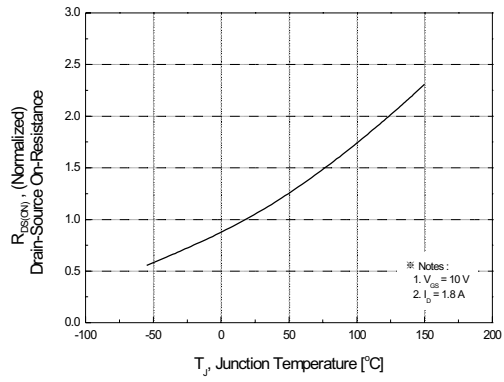


Figure 8. On-Resistance Variation vs. Temperature

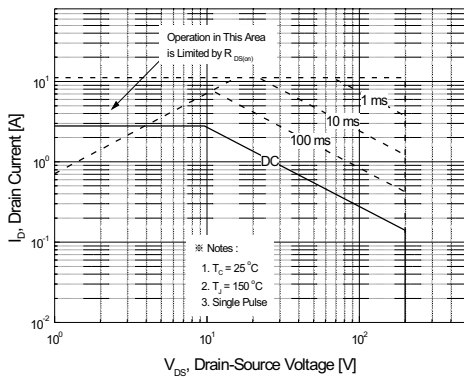


Figure 9. Maximum Safe Operating Area

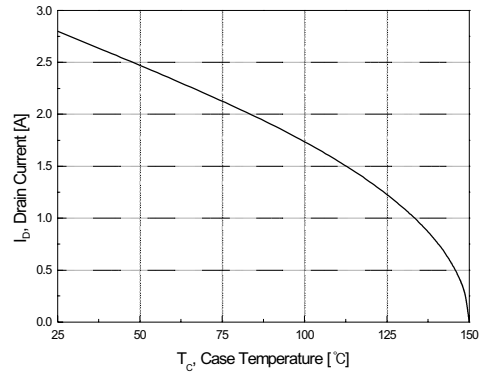


Figure 10. Maximum Drain Current vs. Case Temperature

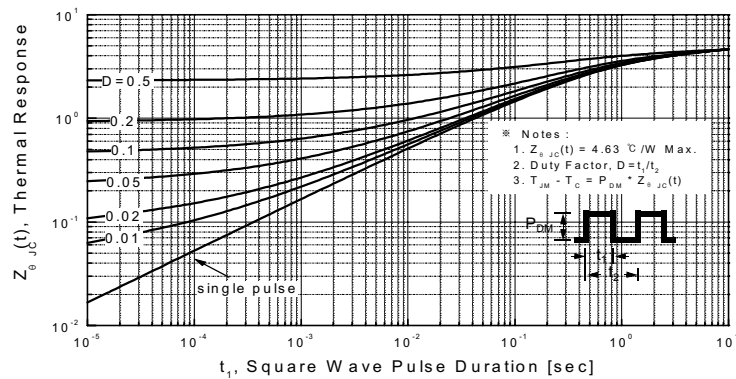
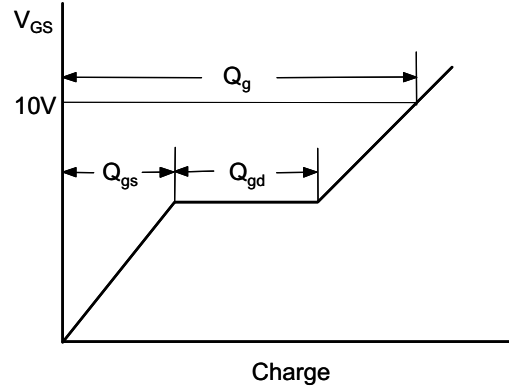
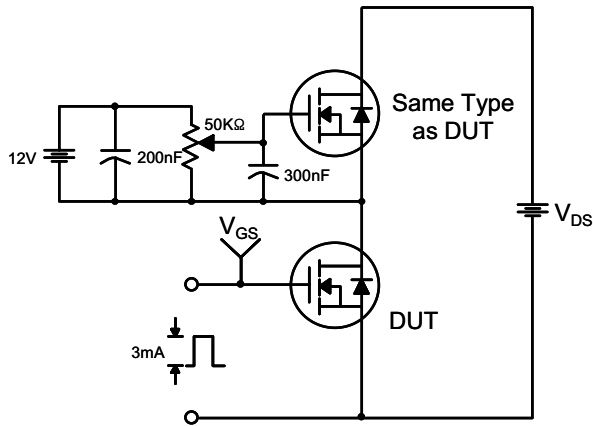
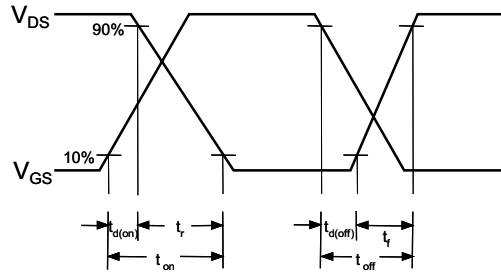
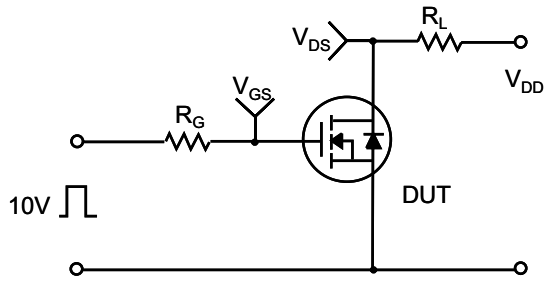


Figure 11. Transient Thermal Response Curve

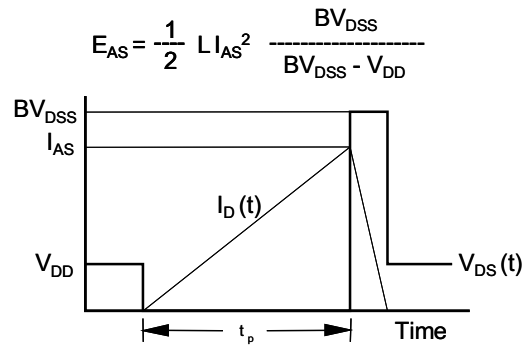
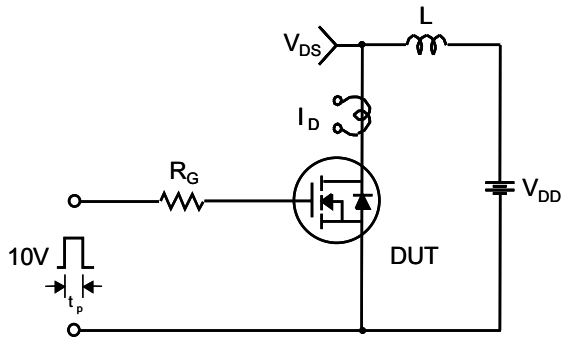
Gate Charge Test Circuit & Waveform



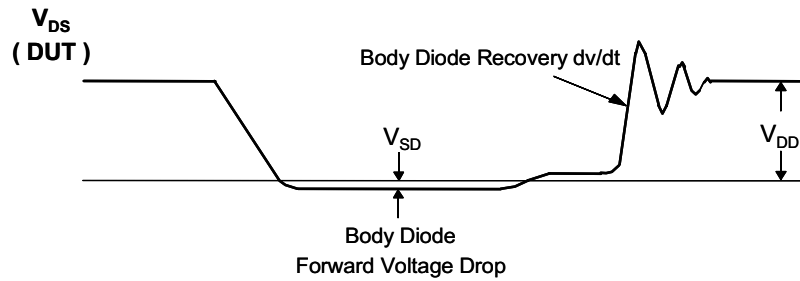
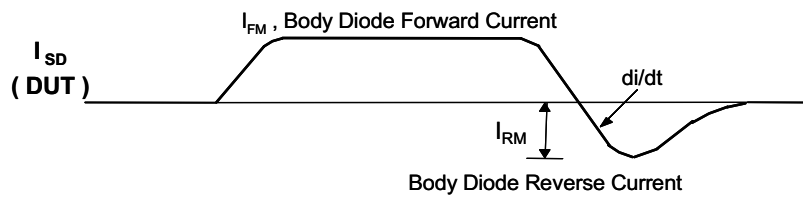
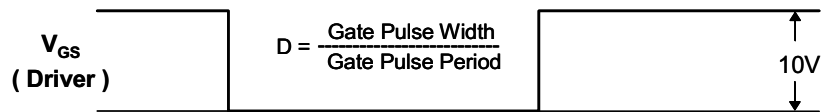
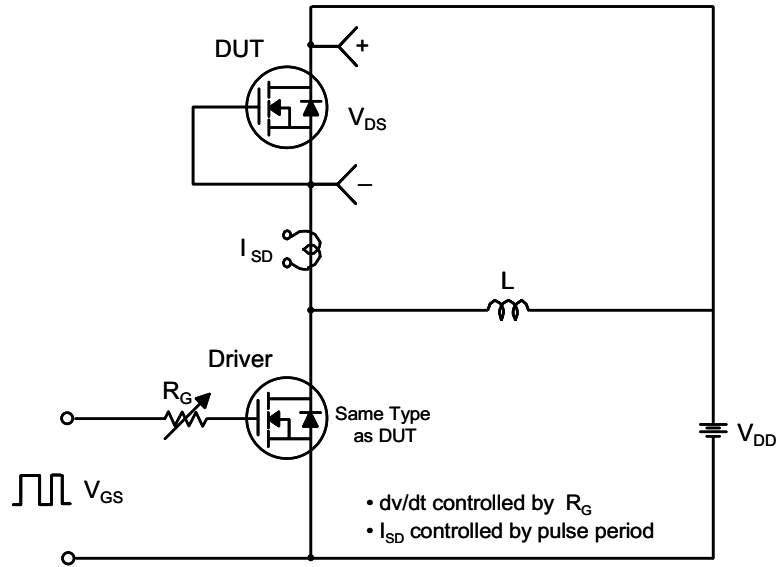
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

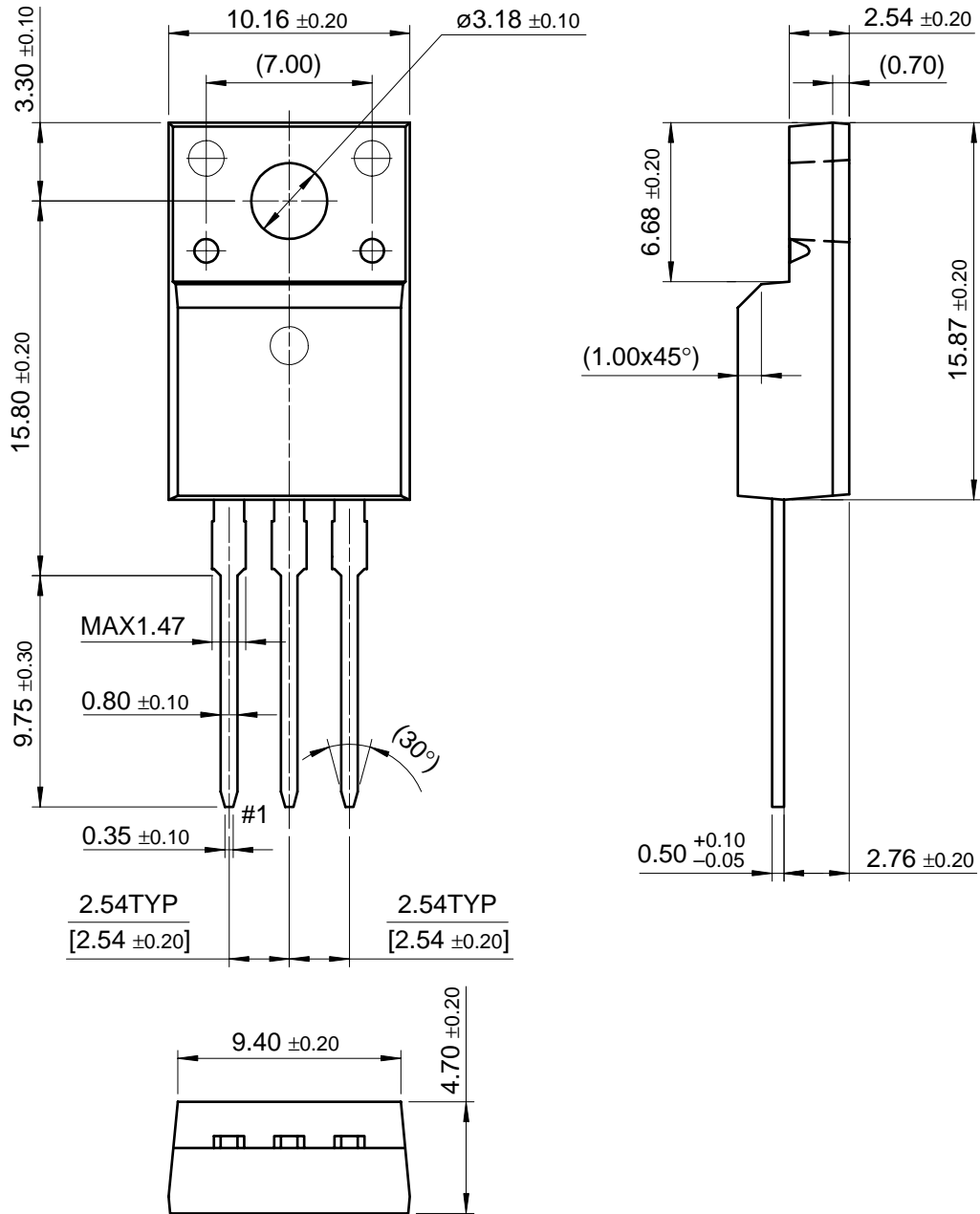


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimensions

TO-220F



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Datasheet Identification	Product Status	Definition
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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